

**Search Notes**

Application/Control No.

10/627,316

Examiner

CHUC D. TRAN

Applicant(s)/Patent under  
Reexamination

NEILL ET AL.

Art Unit

2821

**SEARCHED**

Class	Subclass	Date	Examiner
343	700ms 368,777 860	2/28/2009	TC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
343	700MS	2/28/2009	TC
East Interference Search		2/28/2009	TC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS Consulted with Primary Hoang Nguyen	2/28/2009	TC